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_	10/773,587	02/06/2004	Masahiro Takahashi	0553-0397	6735
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The time period for reply, if any, is set in the attached communication.

Paper No(s)/Mail Date

3) Information Disclosure Statement(s) (PTO/SB/08)

6) Other:

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### **DETAILED ACTION**

### Continued Examination Under 37 CFR 1.114

A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on May 21, 2007 has been entered.

Claims 1-39 are pending in the instant application.

### Claim Objections

Claim 2 objected to under 37 CFR 1.75 as being a substantial duplicate of claim1. When two claims in an application are duplicates or else are so close in content that they both cover the same thing, despite a slight difference in wording, it is proper after allowing one claim to object to the other as being a substantial duplicate of the allowed claim. See MPEP § 706.03(k).

Appropriate correction is required.

# Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

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(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 1, 2, 4, 9 -11,14, 20 - 21, 23,28 –30 and 33 are rejected under 35 U.S.C. 103(a) as being unpatentable over U.S. Patent 6,689,492 to Yamazaki et al., and further in view of U.S. Patent 5,003,221 to Shimizu.

Regarding claim 1 Yamazaki discloses (Fig. 1, column 3 lines 25-47, column 6 lines 48-61, column 9 lines 10-31) a light emitting device comprising substrate 11 having insulating surface, a transparent film 41 formed over the substrate, a first electrode 46 formed over the substrate, a layer including an organic compound 47 formed over the first electrode and a second electrode 48 formed over the organic compound.

Yamazaki is silent about the refractive index of the transparent film gradually varying from an interface at the side of the substrate to an interface at a side of the first electrode.

Shimizu in relevant art of EL displays discloses (Fig. 2 column 3 lines 11-28, column 4 lines 30-48, column 7 lines 5-29) an EL element comprising a substrate 11, a transparent film 12 formed over the substrate and a transparent first electrode 13 formed over the transparent film wherein the refractive index of the transparent film 12 gradually increases from the interface at the side of the substrate (glass with refractive index 1.5) to the interface at the side of the first electrode (made of ITO with refractive index 1.9). Shimizu teaches that this configuration minimizes reflection at interfaces between the layers and can efficiently emit light with high luminance.

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Therefore it would have been obvious to one of ordinary skill in the art at the time of invention to include the transparent film formed over the substrate wherein the refractive index of the transparent film gradually varies from the interface at a side of the substrate to the interface at the side of the first electrode of Yamazaki as taught by Shimizu for minimizing reflection at interfaces between the layers and efficiently light emission with high luminance.

Regarding claim 4 Yamazaki discloses (Figs. 16A-16F column 32 lines 1-36) the light emitting device is incorporated in video camera, playback DVD, mobile computers.

Regarding claim 9 Yamazaki and Shimizu disclose all the limitations which are same as of claim 1 and additionally discloses (Shimizu Fig.2 column 7 lines 5-29) the transparent film comprises plurality of substances which includes a first substance oxygen and a second substance silica and the composition ratio of the second substance to the first substance gradually varies from an interface at a side of the substrate to the interface at the side of the first electrode.

Regarding claim 10 Yamazaki and Shimizu (Shimizu column 5 lines 59-66) disclose the composition ratio of silica (second substance) to the first substance oxygen gradually increases (oxygen decreasing from x=1.8) near the interface at the side of the transparent substrate to (oxygen x=1.0) at the side of the first electrode).

Claims 11 and 14 essentially recite the same limitations as of claim 2 and 4 respectively and hence are rejected for the same reasons.

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Claims 20,21 and 23 recite the limitations for the method of making the light emitting device which are essentially same as those of claims 1,2 and 4 and hence are rejected for the same reasons.

Claims 28-30 and 33 recite the limitations for the method of making the light emitting device which are essentially same as those of claims 9-11 and 14 respectively and hence are rejected for the same reasons.

Claims 5,6,8,15,16,19,24,25,27, 34-36 and 39 are rejected under 35 U.S.C. 103(a) as being unpatentable over U.S. Patent 6,894,431 to Yamazaki et al., and further in view of U.S. Patent 5,003,221 to Shimizu.

Yamazaki ('431)discloses (Fig. 7 column 10 lines 20-42) a substrate 400 having insulating surface, a first electrode (cathode)701 formed over the substrate, a layer of an organic compound formed over the first electrode, a second electrode (transparent anode)702 formed over the organic compound layer. Yamazaki discloses the configuration is reversed in a way such that light is emitted in a direction towards the upper electrode (direction indicated by an arrow).

Shimizu discloses (Figs. 1,2) the transparent film of SiOx is formed between the transparent substrate and a layer formed adjacent to the transparent substrate, the first electrode and the refractive index is gradually varied so that the refractive index of the transparent film is approximated to those of the first electrode and the substrate at the

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interfaces in the direction of the light emission so that reflection at interfaces is minimized and EL element can efficiently emit light with high luminance.

Hence it would have been obvious to one of ordinary skill in the art at the time of invention to modify the second electrode of Yamazaki having a transparent film with gradually varying refractive index formed over the second electrode as taught by Shimizu so that the refractive index of the film is approximated to those of the second electrode and that of air at the interface with air outside in the direction of light emission for minimizing reflection at interfaces between the layers and efficiently light emission with high luminance.

Regarding claim 6 it would have been obvious to specify the refractive index of the transparent film of Yamazaki and Shimizu gradually decreasing from the interface at the side of the second electrode (made of ITO with refractive index 1.9) towards the outside (air having refractive index 1.0) in the direction of light emission in a film thickness direction.

Regarding claim 8 Yamazaki discloses (Figs. 8, 9 column 11 lines 42-65) the light emitting device is incorporated in video camera, playback DVD, mobile computers.

Regarding claim 15 Yamazaki and Shimizu disclose all the limitations same as of claim 5 and additionally disclose (Shimizu Fig.2 column 7 lines 5-29) the transparent film comprises plurality of substances which includes a first substance silica and a second substance oxygen and the composition ratio of the second substance to the first substance gradually varies from an interface the interface at the side of the second electrode in film thickness direction.

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Regarding claim 16 it would be obvious to specify the composition ratio of the second substance (oxygen ) to the first substance (silica) gradually increases from the interface a the side of the second electrode towards outside in the film thickness direction.

Regarding claim 19 Yamazaki discloses (Figs. 8, 9 column 11 lines 42-65) the light emitting device is incorporated in video camera, playback DVD, mobile computers.

Claims 24.25 and 27 recite the limitations for the method of making the light emitting device which are essentially same as those of claims 5,6 and 8 and hence are rejected for the same reasons.

Claims 34,35 and 39 recite the limitations for the method of making the light emitting device which are essentially same as those of claims 15,16 and 19 respectively and hence are rejected for the same reasons.

Regarding claim 36 Yamazaki and Shimizu disclose the transparent film formed on the second electrode such that refractive index of the transparent film gradually decreases from an interface of the second electrode (from 1.9 to 1.0) in the film thickness direction.

Claims 3, 12,13, 22, 31, 32 are rejected under 35 U.S.C. 103(a) as being unpatentable over U.S. Patent 6,689,492 to Yamazaki et al., U.S. Patent 5,003,221 to Shimizu and further in view of U.S. Patent Application Publication 20010016262 to Toyoshima et al.

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Regarding claims 3, 12, 22, 31 and 37 Yamazaki and Shimizu do not exemplify the transparent film with varying refractive index comprising silicon oxynitride.

Toyoshima in pertinent art discloses (para [0009],[0013]) a film formed with silicon as target and oxygen and nitrogen used as reactive sputtering gas components so that silicon oxynitride film is formed having refractive index distributed broadly from 1.48 (refractive index of SiO<sub>2</sub>) to 2.1 (refractive index of Si<sub>3</sub>N<sub>4</sub>). Toyoshima further teaches that this coating with changing amount of nitrogen and oxygen is transparent and shows no substantial absorption of visible light.

Therefore it would have been obvious to one of ordinary skill inn the art at the time the invention was made to use transparent silicon oxynitride as the transparent film of Yamazaki and Shimizu as taught by Toyoshima since it has been held to be within the general skill of the worker in the art to select a known material based on its suitability for the intended use (MPEP 2144.07).

Regarding claims 13,18, 32 and 38 Toyoshima discloses the first substance comprises nitrogen and the second substance comprises oxygen.

Claims 7,17,18, 26,37 and 38 are rejected under 35 U.S.C. 103(a) as being unpatentable over U.S. Patent 6,894,431 to Yamazaki et al. ('431), U.S. Patent 5,003,221 to Shimizu and further in view of U.S. Patent Application Publication 20010016262 to Toyoshima et al.

Regarding claims 7, 17, 26 and 37 Yamazaki ('431)and Shimizu do not exemplify the transparent film with varying refractive index comprising silicon oxynitride.

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Toyoshima in pertinent art discloses (para [0009],[0013]) a film formed with silicon as target and oxygen and nitrogen used as reactive sputtering gas components so that silicon oxynitride film is formed having refractive index distributed broadly from 1.48 (refractive index of SiO<sub>2</sub>) to 2.1 (refractive index of Si<sub>3</sub>N<sub>4</sub>). Toyoshima further teaches that this coating with changing amount of nitrogen and oxygen is transparent and shows no substantial absorption of visible light.

Therefore it would have been obvious to one of ordinary skill inn the art at the time the invention was made to use transparent silicon oxynitride as the transparent film of Yamazaki and Shimizu as taught by Toyoshima since it has been held to be within the general skill of the worker in the art to select a known material based on its suitability for the intended use (MPEP 2144.07).

Regarding claims 18, and 38 Toyoshima discloses the first substance comprises nitrogen and the second substance comprises oxygen.

## Response to Arguments

Applicant's arguments with respect to claims 1-4, 9-14,20-23 and 28-33 have been considered but are most in view of the new ground(s) of rejection.

Applicant's regarding claims 5-8, 15-19,24-27 and 34-39 have been fully considered but they are not persuasive.

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In response to applicant's argument regarding claims 5, 15, 24, 34 that problem to be solved between Yamazaki ('431) and Shimizu is different and there is no motivation to combine the Examiner respectfully disagrees. It is well known in the art to form a passivation film (barrier film) on the second electrode when light is emitting from the top of second electrode for protecting EL element. Shimizu discloses (Figs. 1,2) the transparent film of SiOx is formed between the transparent substrate and a layer formed adjacent to the transparent substrate, the first electrode and the refractive index is gradually varied so that the refractive index of the transparent film is approximated to those of the first electrode and the substrate at the interfaces in the direction of the light emission so that reflection at interfaces is minimized and EL element can efficiently emit light with high luminance. It would have been obvious to one of ordinary skill in the art at the time of invention to form on the second electrode of Yamazaki a transparent film ( a barrier film) with gradually varying refractive index formed over the second electrode as taught by Shimizu so that the refractive index of the film is approximated to those of the second electrode and that of air at the interface with air outside in the direction of light emission for minimizing reflection at interfaces between the layers and efficiently light emission with high luminance.

#### **Contact Information**

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Sikha Roy whose telephone number is (571) 272-2463. The examiner can normally be reached on Monday-Friday 8:00 a.m. - 4:30 p.m.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nimeshkumar D. Patel can be reached on (571) 272-2457. The fax phone number for the organization is (571) 273-8300.

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Sikhar Roy

Sikha Roy Primary Examiner Art Unit 2879